

Notice of References Cited		Application/Control No. 10/593,470	Applicant(s)/Patent Under Reexamination MIYAMOTO ET AL.	
		Examiner JOHN K. KIM	Art Unit 2834	Page 1 of 1

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NON-PATENT DOCUMENTS

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U	01037334.pdf : Jong et al (2002 IEEE publication, "Smart Silicon Sensor – Example of Hall Effect Sensors")
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a))
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